

# Search Notes



Application/Control No.

10/632,228

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

CHAUVEL ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	118	8/21/05	H2
	3		
	115		
Text search			
only - see			
EAST print out			
updated above		using EAST	
711	215	3/16/06	H2
- Text search			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG - Pub	-	Text search	
		3/16/06	H2

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	8/21/05	H2
NPL search using terms similar to EAST search.		
Inventorship search.		
Updated EAST search	3/16/06	H2